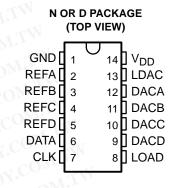
# TLC5620C, TLC5620I QUADRUPLE 8-BIT DIGITAL-TO-ANALOG CONVERTERS

SLAS081E - NOVEMBER 1994 - REVISED NOVEMBER 2001

- Four 8-Bit Voltage Output DACs
- 5-V Single-Supply Operation
- Serial Interface
- High-Impedance Reference Inputs
- Programmable 1 or 2 Times Output Range
- Simultaneous Update Facility
- Internal Power-On Reset
- Low-Power Consumption
- Half-Buffered Output

## applications

- Programmable Voltage Sources
- Digitally Controlled Amplifiers/Attenuators
- Mobile Communications
- Automatic Test Equipment
- Process Monitoring and Control
- Signal Synthesis



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## description

The TLC5620C and TLC5620I are quadruple 8-bit voltage output digital-to-analog converters (DACs) with buffered reference inputs (high impedance). The DACs produce an output voltage that ranges between either one or two times the reference voltages and GND, and the DACs are monotonic. The device is simple to use, running from a single supply of 5 V. A power-on reset function is incorporated to ensure repeatable start-up conditions.

Digital control of the TLC5620C and TLC5620I are over a simple three-wire serial bus that is CMOS compatible and easily interfaced to all popular microprocessor and microcontroller devices. The 11-bit command word comprises eight bits of data, two DAC-select bits, and a range bit, the latter allowing selection between the times 1 or times 2 output range. The DAC registers are double buffered, allowing a complete set of new values to be written to the device, then all DAC outputs are updated simultaneously through control of LDAC. The digital inputs feature Schmitt triggers for high noise immunity.

The 14-terminal small-outline (D) package allows digital control of analog functions in space-critical applications. The TLC5620C is characterized for operation from 0°C to 70°C. The TLC5620I is characterized for operation from -40°C to 85°C. The TLC5620C and TLC5620I do not require external trimming.

## **AVAILABLE OPTIONS**

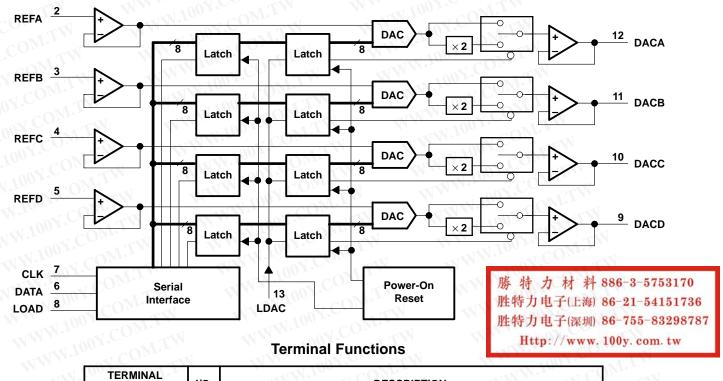
PACKAGE								
CO TA	SMALL OUTLINE (D)	PLASTIC DIP (N)						
0°C to 70°C	TLC5620CD	TLC5620CN						
-40°C to 85°C	TLC5620ID	TLC5620IN						



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



## functional block diagram



TERMINAL		1/0	DESCRIPTION
NAME	NO.		W 100 5 BEGONII HON
CLK	7 COM		Serial interface clock. The input digital data is shifted into the serial interface register on the falling edge of the clock applied to the CLK terminal.
DACA	12	0	DAC A analog output
DACB	11	0	DAC B analog output
DACC	10	0	DAC C analog output
DACD	9	0	DAC D analog output
DATA	6 100 Y.C		Serial interface digital data input. The digital code for the DAC is clocked into the serial interface register serially. Each data bit is clocked into the register on the falling edge of the clock signal.
GND	101	Jo	Ground return and reference terminal
LDAC	13	N.C	Load DAC. When the LDAC signal is high, no DAC output updates occur when the input digital data is read into the serial interface. The DAC outputs are only updated when LDAC is taken from high to low.
LOAD	8	100X	Serial Interface load control. When LDAC is low, the falling edge of the LOAD signal latches the digital data into the output latch and immediately produces the analog voltage at the DAC output terminal.
REFA 🦪	2	40	Reference voltage input to DAC A. This voltage defines the output analog range.
REFB	3	r I	Reference voltage input to DAC B. This voltage defines the output analog range.
REFC	4	VYO	Reference voltage input to DAC C. This voltage defines the output analog range.
REFD	5	11	Reference voltage input to DAC D. This voltage defines the output analog range.
$V_{DD}$	14	ĬÌ,	Positive supply voltage

WWW.100

## detailed description

The TLC5620 is implemented using four resistor-string DACs. The core of each DAC is a single resistor with 256 taps, corresponding to the 256 possible codes listed in Table 1. One end of each resistor string is connected to the GND terminal and the other end is fed from the output of the reference input buffer. Monotonicity is maintained by use of the resistor strings. Linearity depends upon the matching of the resistor elements and upon the performance of the output buffer. Since the inputs are buffered, the DACs always present a high-impedance load to the reference source.

Each DAC output is buffered by a configurable-gain output amplifier that can be programmed to times 1 or times 2 gain.

On power up, the DACs are reset to CODE 0.

Each output voltage is given by:

$$V_O(DACA|B|C|D) = REF \times \frac{CODE}{256} \times (1 + RNG \text{ bit value})$$

where CODE is in the range 0 to 255 and the range (RNG) bit is 0 or 1 within the serial control word.

D7	D6	D5	D4	D3	D2	D1	D0	OUTPUT VOLTAGE
0	0	0	0	0	0	0	0	GND
0	0	0	0	0	0	0	1	(1/256) × REF (1+RNG)
	•	• "	•	0£ $N$	0 7.	CON		, M.100
TV	•	•	W.Y.	1	00-7	•	(T.)	W W 100
0	1	1	1	1	1	.9	1	(127/256) × REF (1+RNG)
1	0	0	0	0	0	0	0	(128/256) × REF (1+RNG)
1.	LA	•	•		V.1.0V	•	0.1	•
•1	TiV	•	• 1	11,	·(()	07.	•	TW . WY
1	1	<b>1</b>	1	1	1	011	1	(255/256) × REF (1+RNG)

**Table 1. Ideal Output Transfer** 

#### data interface

With LOAD high, data is clocked into the DATA terminal on each falling edge of CLK. Once all data bits have been clocked in, LOAD is pulsed low to transfer the data from the serial input register to the selected DAC as shown in Figure 1. When LDAC is low, the selected DAC output voltage is updated when LOAD goes low. When LDAC is high during serial programming, the new value is stored within the device and can be transferred to the DAC output at a later time by pulsing LDAC low as shown in Figure 2. Data is entered most significant bit (MSB) first. Data transfers using two 8-clock cycle periods are shown in Figures 3 and 4.

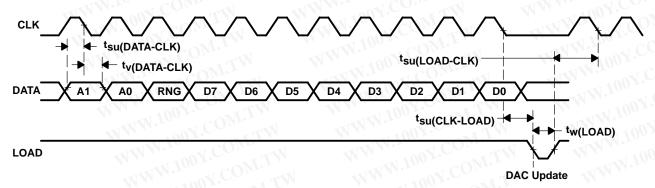
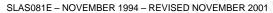


Figure 1. LOAD-Controlled Update (LDAC = Low)





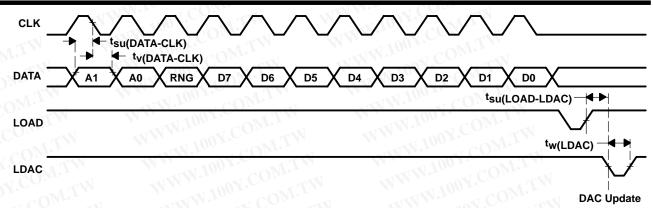


Figure 2. LDAC-Controlled Update

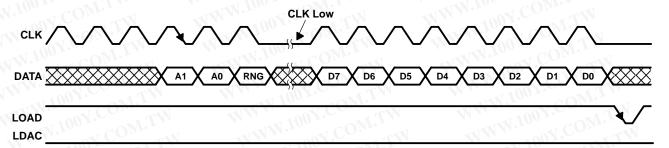


Figure 3. Load-Controlled Update Using 8-Bit Serial Word (LDAC = Low)

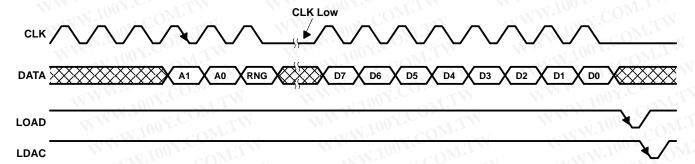


Figure 4. LDAC-Controlled Update Using 8-Bit Serial Word

Table 2 lists the A1 and A0 bits and the selection of the updated DACs. The RNG bit controls the DAC output range. When RNG = low, the output range is between the applied reference voltage and GND, and when RNG = high, the range is between twice the applied reference voltage and GND.

**Table 2. Serial Input Decode** 

A1	A0	DAC UPDATED
0	0	DACA
0	1	DACB
100	0	DACC
)V 1	1.1	DACD



## linearity, offset, and gain error using single-end supplies

When an amplifier is operated from a single supply, the voltage offset can still be either positive or negative. With a positive offset voltage, the output voltage changes on the first code change. With a negative offset the output voltage may not change with the first code depending on the magnitude of the offset voltage.

The output amplifier attempts to drive the output to a negative voltage. However, because the most negative supply rail is ground, the output cannot drive below ground and clamps the output at 0 V.

The output voltage then remains at zero until the input code value produces a sufficient positive output voltage to overcome the negative offset voltage, resulting in the transfer function shown in Figure 5.

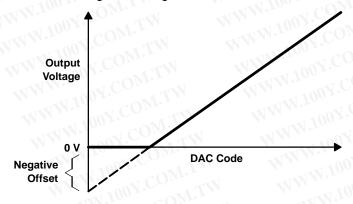


Figure 5. Effect of Negative Offset (Single Supply)

This offset error, not the linearity error, produces this breakpoint. The transfer function would have followed the dotted line if the output buffer could drive below ground.

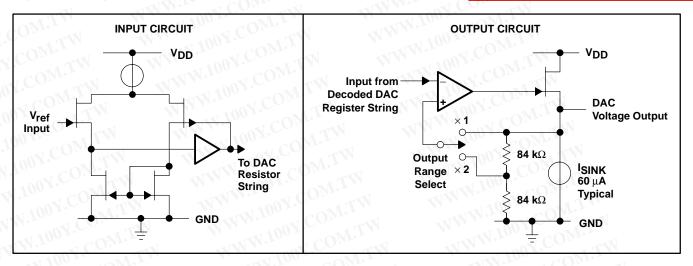
For a DAC, linearity is measured between zero-input code (all inputs 0) and full-scale code (all inputs 1) after offset and full scale are adjusted out or accounted for in some way. However, single-supply operation does not allow for adjustment when the offset is negative due to the breakpoint in the transfer function. So the linearity is measured between full-scale code and the lowest code that produces a positive output voltage. The code is calculated from the maximum specification for the negative offset voltage.

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## equivalent inputs and outputs



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage (V <sub>DD</sub> – GND)	7 V
Digital input voltage range	
Reference input voltage range, V <sub>ID</sub>	GND $- 0.3 \text{ V to V}_{DD} + 0.3 \text{ V}$
Operating free-air temperature range, T <sub>A</sub> : TLC5620C	0°C to 70°C
TLC5620I	–40°C to 85°C
Storage temperature range, T <sub>stq</sub>	–50°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## recommended operating conditions

MAN. CON	TW WWW. COM T	MIN	NOM	MAX	UNIT
Supply voltage, V <sub>DD</sub>	4.75	WW	5.25	( V)	
High-level input voltage, VIH	W.I., W. In. COM.	0.8 V <sub>DD</sub>		M. Jos	V (
Low-level input voltage, V <sub>IL</sub>	W.TW WW. 100Y.	1.7		0.8	V
Reference voltage, V <sub>ref</sub> [A B C D]	O. TW WWW. 100X.CO.		V	V <sub>DD</sub> -1.5	V
Analog full-scale output voltage, $R_L = 10 \text{ Hz}$	$\Omega$	TW	3.5	MM	V.
Load resistance, R <sub>L</sub>	COMITY	10		TWW.	kΩ
Setup time, data input, t <sub>SU(DATA-CLK)</sub> (se	ee Figures 1 and 2)	50		1	ns
Valid time, data input valid after CLK $\downarrow$ , $t_{V(}$	DATA-CLK) (see Figures 1 and 2)	50		M.A.	ns
Setup time, CLK eleventh falling edge to L	OAD, t <sub>su(CLK-LOAD)</sub> (see Figure 1)	50	N	MM	ns
Setup time, LOAD↑ to CLK↓, t <sub>Su(LOAD-C</sub>	CLK) (see Figure 1)	50	W	WY	ns
Pulse duration, LOAD, tw(LOAD) (see Fig	ure 1)	250	-XXI		ns
Pulse duration, LDAC, tw(LDAC) (see Fig	ure 2)	250	1		ns
Setup time, LOAD↑ to LDAC↓, t <sub>SU(LOAD</sub>	0	1.1.11		ns	
CLK frequency	WW.CO.YO	W.Co.	TW	1	MHz
On the first state of the T	TLC5620C	0.00	T	70	°C
Operating free-air temperature, T <sub>A</sub>	TLC5620I	-40	Dir	85	°C



## electrical characteristics over recommended operating free-air temperature range, $V_{DD}$ = 5 V $\pm$ 5%, $V_{ref} = 2 V_1 \times 1$ gain output range (unless otherwise noted)

TIN	PARAMETER		T CONDITIONS	MIN	TYP	MAX	UNIT
Ин I	High-level input current	$V_I = V_{DD}$	$V_I = V_{DD}$			±10	μΑ
111	Low-level input current	V <sub>I</sub> = 0 V	N.100 COM.	-<1		±10	μΑ
I <sub>O(sink)</sub>	Output sink current	Each DAC or	I.Mo. TOOLIN	20			μΑ
I <sub>O(source)</sub>	Output source current	Each DAC 0	uthat	2			mA
$co^{M.1}$	Input capacitance	XIX XXIX	TAMAN TOOK COM		15		nE.
Ci	Reference input capacitance	- 1			15		pF
I <sub>DD</sub>	Supply current	$V_{DD} = 5 V$	V <sub>DD</sub> = 5 V			2	mA
I <sub>ref</sub>	Reference input current	$V_{DD} = 5 V$	V <sub>ref</sub> = 2 V	TI	N	±10	μΑ
EL CON	Linearity error (end point corrected)	$V_{ref} = 2 V$ ,	×2 gain (see Note 1)	17.	W	±1	LSB
ED	Differential-linearity error	$V_{ref} = 2 V$ ,	×2 gain (see Note 2)	$O_{MT}$ .,	- 1	±0.9	LSB
EZS	Zero-scale error	$V_{ref} = 2 V$ ,	×2 gain (see Note 3)	0	In	30	mV
OV.CI	Zero-scale-error temperature coefficient	$V_{ref} = 2 V$ ,	×2 gain (see Note 4)		10		μV/°C
EFS	Full-scale error	$V_{ref} = 2 V$ ,	×2 gain (see Note 5)	$^{\circ}CO_{\mathbb{R}}$	W	±60	mV
$100_{T}$	Full-scale-error temperature coefficient	$V_{ref} = 2 V$	×2 gain (see Note 6)	<1 CO	±25	N.	μV/°C
PSRR	Power-supply rejection ratio	See Notes 7	See Notes 7 and 8		0.5	*	mV/V

- Integral nonlinearity (INL) is the maximum deviation of the output from the line between zero and full scale (excluding the effects of zero code and full-scale errors).
  - 2. Differential nonlinearity (DNL) is the difference between the measured and ideal 1 LSB amplitude change of any two adjacent codes. Monotonic means the output voltage changes in the same direction (or remains constant) as a change in the digital input code.
  - 3. Zero-scale error is the deviation from zero voltage output when the digital input code is zero.
  - $\label{eq:ZSETC} \textit{Zero-scale-error temperature coefficient is given by: ZSETC = [ZSE(T_{max}) ZSE(T_{min})]/V_{ref} \times 10^6/(T_{max} T_{min}).$

  - Full-scale error is the deviation from the ideal full-scale output (V<sub>ref</sub> 1 LSB) with an output load of 10 kΩ.
     Full-scale-error temperature coefficient is given by: FSETC = [FSE(T<sub>max</sub>) FSE (T<sub>min</sub>)]/V<sub>ref</sub> × 10<sup>6</sup>/(T<sub>max</sub> T<sub>min</sub>).
  - 7. Zero-scale-error rejection ratio (ZSE RR) is measured by varying the VDD from 4.5 V to 5.5 V dc and measuring the proportion of this signal imposed on the zero-code output voltage.
  - 8. Full-scale-error rejection ratio (FSE RR) is measured by varying the VDD from 4.5 V to 5.5 V dc and measuring the proportion of this signal imposed on the full-scale output voltage.

# operating characteristics over recommended operating free-air temperature range, $V_{DD}$ = 5 V $\pm$ 5%, $V_{ref} = 2 V_{ref} \times 1$ gain output range (unless otherwise noted)

WW. 1007.	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output slew rate	$C_L = 100 \text{ pF},  R_L = 10 \text{ k}\Omega$	41	1	001.	V/µs
Output settling time	To $\pm 0.5$ LSB, $C_L = 100$ pF, $R_L = 10$ k $\Omega$ , See Note 9	W	10	You.	μs
Large-signal bandwidth	Measured at −3 dB point		100	Too	kHz
Digital crosstalk	CLK = 1-MHz square wave measured at DACA-DACD		-50	1.100	dB
Reference feedthrough	See Note 10		-60	x1 10	dB
Channel-to-channel isolation	See Note 11		-60	44.	dB
Reference input bandwidth	See Note 12		100	111.7	kHz

- NOTES: 9. Settling time is the time between a LOAD falling edge and the DAC output reaching full scale voltage within +/-0.5 LSB starting from an initial output voltage equal to zero.

  - 10. Reference feedthrough is measured at any DAC output with an input code = 00 hex with a V<sub>ref</sub> input = 1 V dc + 1 V<sub>pp</sub> at 10 kHz.
     11. Channel-to-channel isolation is measured by setting the input code of one DAC to FF hex and the code of all other DACs to 00 hex with  $V_{ref}$  input = 1 V dc + 1  $V_{pp}$  at 10 kHz.
  - 12. Reference bandwidth is the -3 dB bandwidth with an input at V<sub>ref</sub> = 1.25 V dc + 2 V<sub>pp</sub> and with a full-scale digital-input code.

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## PARAMETER MEASUREMENT INFORMATION

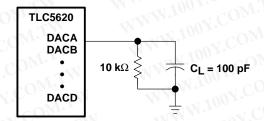
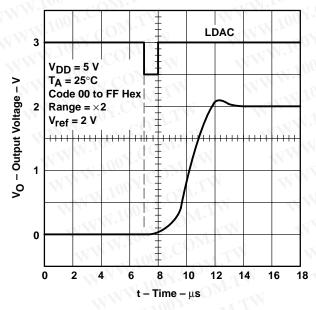


Figure 6. Slew, Settling Time, and Linearity Measurements

#### TYPICAL CHARACTERISTICS

## **POSITIVE RISE AND SETTLING TIME**



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#### **NEGATIVE FALL AND SETTLING TIME**

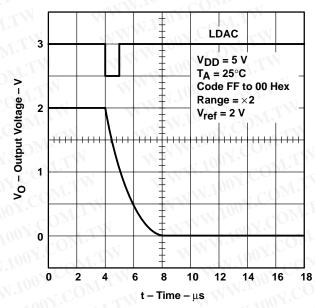


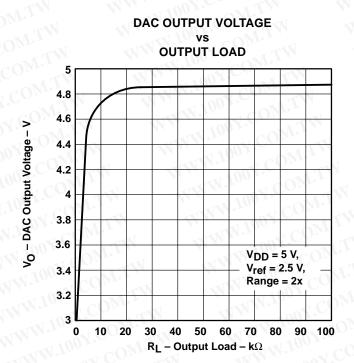
Figure 8



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## TYPICAL CHARACTERISTICS



**DAC OUTPUT VOLTAGE** vs **OUTPUT LOAD** 3.5 V<sub>O</sub> - DAC Output Voltage - V 3 2.5 2 1.5 1  $V_{DD} = 5 V$  $V_{ref} = 3.5 V,$ 0.5 Range = 1x 10 20 30 50 60 70 80 100 0 40 90  $R_L$  - Output Load -  $k\Omega$ 

Figure 9

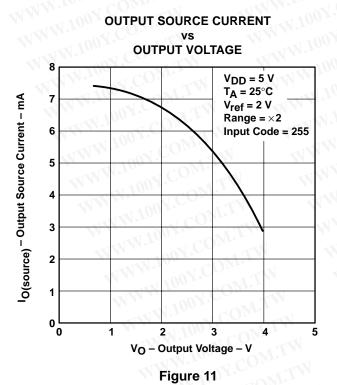


Figure 10

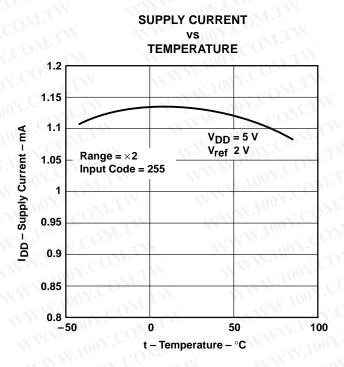
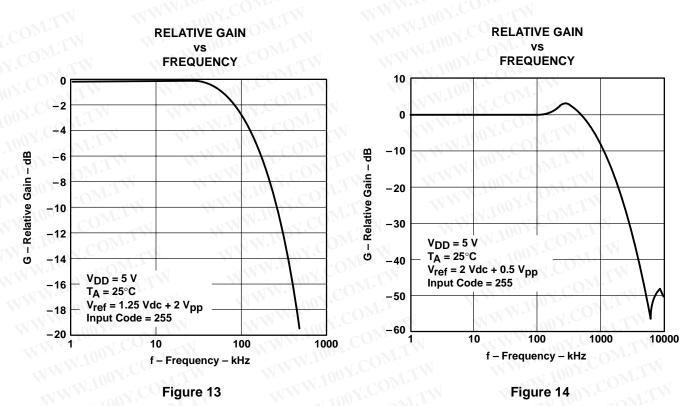
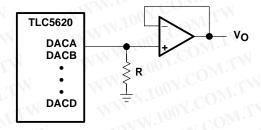


Figure 12

## TYPICAL CHARACTERISTICS



## **APPLICATION INFORMATION**



NOTE A: Resistor R  $\geq$  10 k $\Omega$ 

Figure 15. Output Buffering Scheme

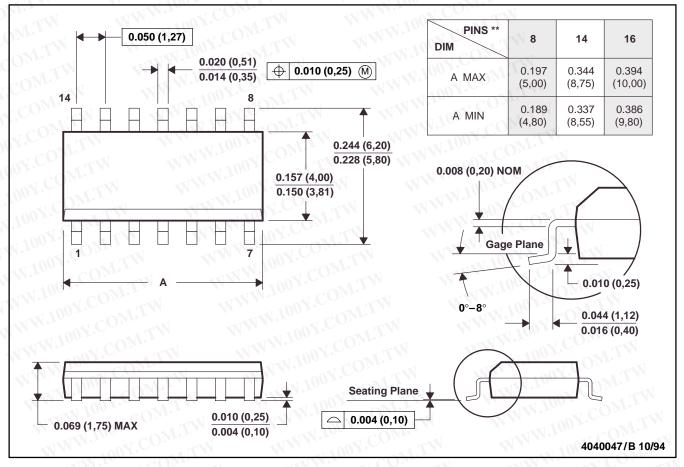


#### **MECHANICAL DATA**

## D (R-PDSO-G\*\*)

#### 14 PIN SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

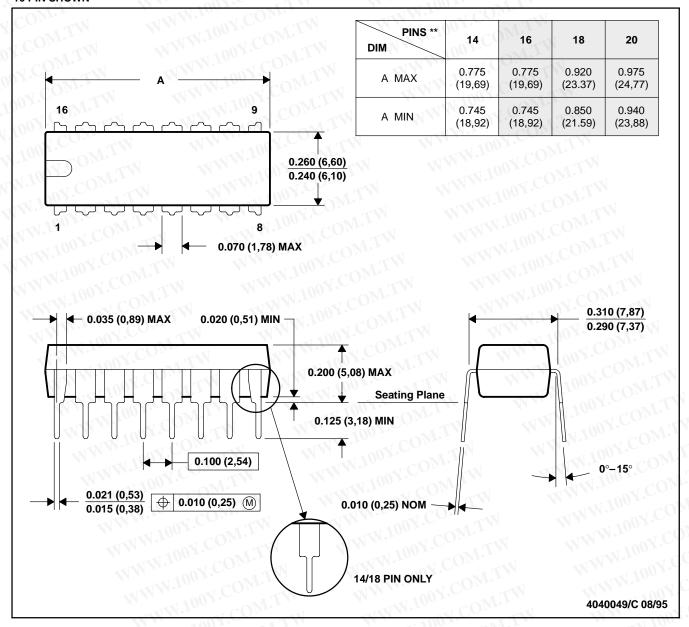
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Four center pins are connected to die mount pad.
- E. Falls within JEDEC MS-012

#### **MECHANICAL DATA**

## N (R-PDIP-T\*\*)

### **16 PIN SHOWN**

### PLASTIC DUAL-IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-001 (20-pin package is shorter than MS-001)



# PACKAGE OPTION ADDENDUM



com 18-Feb-2005

## **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins Pa	ackage Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
TLC5620CD	ACTIVE	SOIC	D	14	50	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC5620CDR	ACTIVE	SOIC	D	14	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC5620CN	ACTIVE	PDIP	N	14	25	Pb-Free (RoHS)	CU NIPDAU	Level-NA-NA-NA
TLC5620ID	ACTIVE	SOIC	OMD	14	50	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC5620IDR	ACTIVE	SOIC	OD.	14	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC5620IN	ACTIVE	PDIP	CON	14	25	Pb-Free (RoHS)	CU NIPDAU	Level-NA-NA-NA

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

None: Not yet available Lead (Pb-Free).

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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